Search Notes



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Examiner

Applicant(s)/Patent Under Reexamination

DEZONNO ET AL.

Art Unit

MATTHEW W GENACK

2617

SEARCHED Class Subclass Date Examiner

SEARCH NOTES						
Search Notes	Date	Examiner				
Reviewed IDS documents	3/4/2005	MG				
Consulted with Primary Examiner Roland Foster	3/4/2005	MG				
Conducted keyword search (See search history printout)	3/4/2005	MG				
379/201.0103, 201.0709,221.1, 221.1113, 265.0103, 266.0309 (Limited text searchsee search history printout)	3/4/2005	MG				
Updated keyword search (See search history printout)	7/23/22005	MG				
Updated keyword search (See search history printout)	2/3/2006	MG				
Reviewed IDS documents	10/16/2006	MG				
Updated keyword search (See search history printout)	10/16/2006	MG				
Updated keyword search (See search history printout)	3/27/2007	MG				
Updated keyword search (See search history printout)	12/19/2007	MG				
Updated keyword search (See search history printout)	9/17/2008	MG				
Updated keyword search (See search history printout)	5/12/2009	MG				
Conducted NPL search with IEEE Xplore (See IEEE Xplore search printouts)	5/12/2009	MG				
Consulted with Primary Examiner James Wozniak	5/12/2009	MG				
Updated keyword search (See search history printout)	1/7/2010	MG				
Consulted with Primary Examiner Patrick Edouard	3/23/2011	MG				
Updated keyword search (See search history printout)	3/23/2011	MG				
Consulted with Primary Examiner Patrick Edouard	2/9/2012	MG				
Updated keyword search (See search history printout)	2/15/2012	MG				

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

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